

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/759,207 CHAN ET AL.	
		Examiner	Art Unit Christy L. Novacek	Page 1 of 1 2822

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0003644	01-2003	Uenishi et al.	438/200
	B	US-6,905,941	06-2005	Doris et al.	438/424
	C	US-			
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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